



# 100V 175°C DUAL N-CHANNEL ENHANCEMENT MODE MOSFET PowerDI5060-8

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>C</sub> = +25°C	
100V	17.4mΩ @ V <sub>GS</sub> = 10V	59A	
	$30.3 \text{m}\Omega$ @ V <sub>GS</sub> = $4.5 \text{V}$	45A	

### **Features and Benefits**

- Rated to +175°C—Ideal for High Ambient Temperature Environments
- 100% Unclamped Inductive Switching (UIS) Test in Production— Ensures More Reliable and Robust End Application
- High Conversion Efficiency
- Low R<sub>DS(ON)</sub>—Minimizes On State Losses
- Low Input Capacitance
- Fast Switching Speed
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The DMTH10H017LPDQ is suitable for automotive applications requiring specific change control; this part is AEC-Q101 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.

https://www.diodes.com/quality/product-definitions/

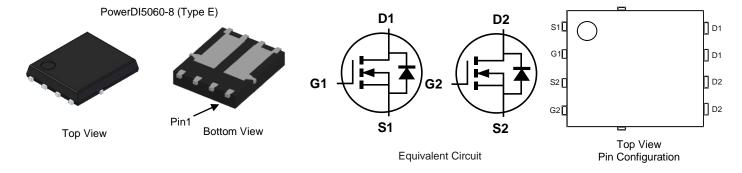
# **Description and Applications**

This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP, and is ideal for use in:

- Synchronous Rectifier
- DC-DC Converters
- Primary Side Switching

### **Mechanical Data**

- Case: PowerDI<sup>®</sup>5060-8
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish—Matte Tin Annealed over Copper Leadframe.
  Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.097 grams (Approximate)



# **Ordering Information** (Note 4)

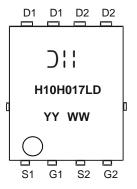
Part Number	Case	Packaging
DMTH10H017LPDQ-13	PowerDI5060-8 (Type E)	2500 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.



### **Marking Information**



⊃¦¦= Manufacturer's Marking H10H017LD = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 19 = 2019) WW = Week (01 to 53)

# **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	VDSS	100	V	
Gate-Source Voltage	Vgss	±20	V	
Continuous Drain Current, V <sub>GS</sub> = 10V (Note 7)	$T_{C} = +25^{\circ}C$ $T_{C} = +100^{\circ}C$	I <sub>D</sub>	59 42	А
T <sub>A</sub> = +25°C Continuous Drain Current, V <sub>GS</sub> = 10V (Note 6) T <sub>A</sub> = +85°C T <sub>A</sub> = +100°C		lσ	13 10 9	А
Maximum Body Diode Forward Current (Note 6)	Is	60	А	
Pulsed Drain Current (10µs Pulse, Tc = +25°C, Package Limited)	I <sub>DM</sub>	236	А	
Pulsed Body Diode Forward Current (10µs Pulse, T <sub>C</sub> = +25°C, Package	Ism	236	Α	
Avalanche Current, L = 3mH (Note 8)	IAS	10	Α	
Avalanche Energy, L = 3mH (Note 8)	Eas	150	mJ	
Avalanche Current, L = 1mH (Note 8)	I <sub>AS</sub>	10	А	
Avalanche Energy, L = 1mH (Note 8)	Eas	50	mJ	

# **Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25$ °C	P <sub>D</sub>	1.5	W
Thermal Resistance, Junction to Ambient (Note 5)		RөJA	100	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	PD	2.6	W
Thermal Resistance, Junction to Ambient (Note 6)	RөJA	56	°C/W	
Total Power Dissipation	$T_C = +25$ °C	P <sub>D</sub>	93	W
Thermal Resistance, Junction to Case (Note 7)		Rejc	1.6	°C/W
Operating and Storage Temperature Range		TJ, TSTG	-55 to +175	°C

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Thermal resistance from junction to solder point (on the exposed drain pin).
- 8.  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J = +25$ °C.



# Electrical Characteristics (@T<sub>C</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)	•		•				
Drain-Source Breakdown Voltage	BVDSS	100	_	_	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 1mA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μA	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 9)	•						
Gate Threshold Voltage	Vgs(TH)	1	_	3	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	
Static Drain-Source On-Resistance	D	_	13.7	17.4	mΩ	V <sub>G</sub> S = 10V, I <sub>D</sub> = 17A	
Static Dialii-Source Off-Resistance	R <sub>DS(ON)</sub>	_	23.8	30.3	11112	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 10A	
Diode Forward Voltage	VsD	_	0.8	1.3	V	V <sub>G</sub> S = 0V, I <sub>S</sub> = 17A	
DYNAMIC CHARACTERISTICS (Note 10)				•	•		
Input Capacitance	Ciss	_	1986	_		V <sub>DS</sub> = 50V, V <sub>GS</sub> = 0V, f = 1MHz	
Output Capacitance	Coss	_	333	_	pF		
Reverse Transfer Capacitance	Crss	_	20	_		1 – 11/11/12	
Gate Resistance	Rg	_	1.17	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	14.4	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	28.6	_	nC	N/ 50\/ 1 00A	
Gate-Source Charge	Qgs	_	5.2	_	IIC	$V_{DS} = 50V, I_{D} = 20A$	
Gate-Drain Charge	Qgd	_	8.2	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	9.8	_		V <sub>DD</sub> = 50V, V <sub>GS</sub> = 10V,	
Turn-On Rise Time	t <sub>R</sub>	_	16.3	_			
Turn-Off Delay Time	tD(OFF)	_	32.6	_	ns	$R_G = 11\Omega, I_D = 20A$	
Turn-Off Fall Time	tF	_	21.6	_			
Body Diode Reverse Recovery Time	t <sub>RR</sub>		40.6	_	ns	I <sub>F</sub> = 17A, di/dt = 100A/μs	
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>	_	58.1	_	nC	I <sub>F</sub> = 17A, di/dt = 100A/µs	

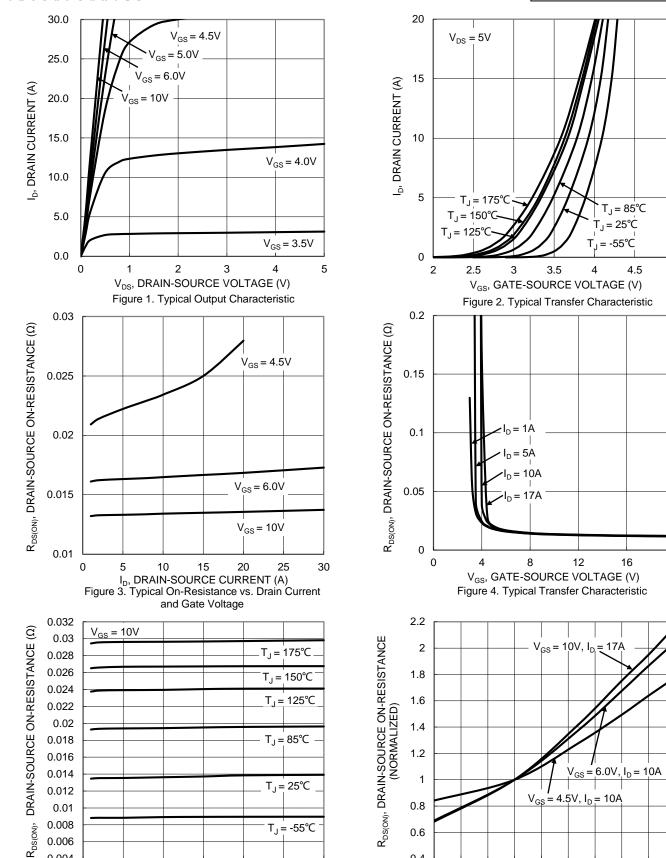
Notes:

<sup>9.</sup> Short duration pulse test used to minimize self-heating effect. 10. Guaranteed by design. Not subject to product testing.

5

20





I<sub>D</sub>, DRAIN CURRENT (A) Figure 5. Typical On-Resistance vs. Drain Current and Temperature

15

20

10

50

25

0

0.008

0.006 0.004 0.6

0.4

-50

75 100 125 150 175

30

 $T_J = -55^{\circ}C$ 

25





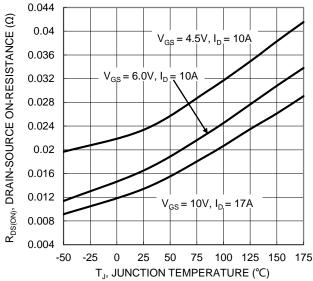


Figure 7. On-Resistance Variation with Temperature

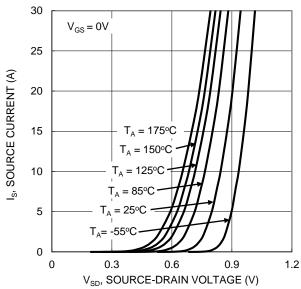


Figure 9. Diode Forward Voltage vs. Current 10 8 6  $V_{GS}(V)$ 4  $V_{DS} = 50V, I_{D} = 20A$ 2 0 25 0 5 10 15 20 30  $Q_q$  (nC)

Figure 11. Gate Charge

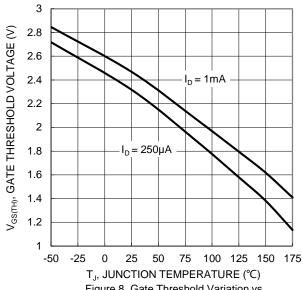


Figure 8. Gate Threshold Variation vs. JunctionTemperature

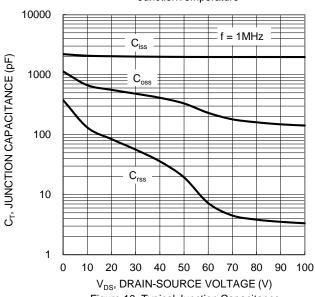


Figure 10. Typical Junction Capacitance

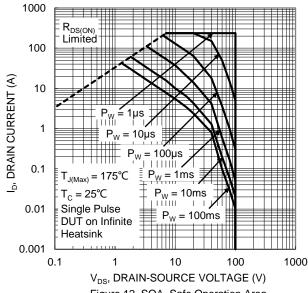


Figure 12. SOA, Safe Operation Area



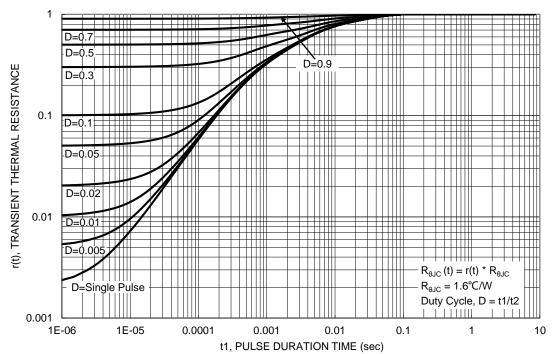


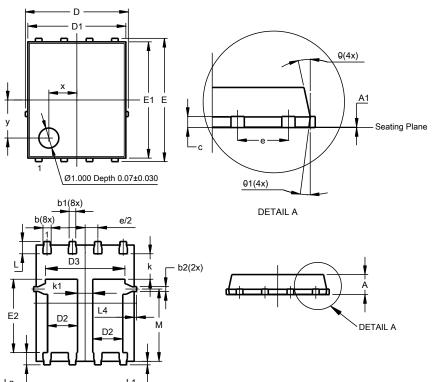
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI5060-8 (Type E)

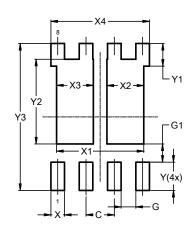


PowerDI5060-8 (Type E)					
Dim	Min	Тур			
Α	0.90	1.10	1.00		
<b>A</b> 1	0	0.05	0.02		
þ	0.33	0.51	0.41		
b1	0.300	0.366	0.333		
b2	0.20	0.35	0.25		
C	0.23	0.33	0.277		
D	5	.15 BS0	$\sim$		
D1	4.85	4.95	4.90		
D2	1.40	1.60	1.50		
D3	_	_	3.98		
Е		.15 BS(			
E1	5.75	5.85	5.80		
E2	3.56	3.76	3.66		
е	1	.27BSC			
k		_	1.27		
k1	0.56	_	_		
L	0.51	0.71	0.61		
La	0.51	0.71	0.61		
L1	0.05	0.20	0.175		
L4		_	0.125		
М	3.50	3.71	3.605		
X		_	1.400		
у		_	1.900		
θ	10°	12°	11°		
θ1	6°	8°	7°		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI5060-8 (Type E)



Dimensions	value		
Dillicitatoria	(in mm)		
С	1.270		
G	0.660		
G1	0.820		
X	0.610		
X1	3.910		
X2	1.650		
Х3	1.650		
X4	4.420		
Y	1.270		
Y1	1.020		
Y2	3.810		
Y3	6.610		



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